International Rectifier

IRLZ24NPbF

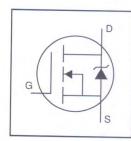
HEXFET® Power MOSFET

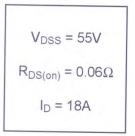
- Logic-Level Gate Drive
- Advanced Process Technology
- Dynamic dv/dt Rating
- 175°C Operating Temperature
- Fast Switching
- Fully Avalanche Rated
- Lead-Free

Description

Fifth Generation HEXFETs from International Rectifier utilize advanced processing techniques to achieve the lowest possible on-resistance per silicon area. This benefit, combined with the fast switching speed and ruggedized device design that HEXFET Power MOSFETs are well known for, provides the designer with an extremely efficient device for use in a wide variety of applications.

The TO-220 package is universally preferred for all commercial-industrial applications at power dissipation levels to approximately 50 watts. The low thermal resistance and low package cost of the TO-220 contribute to its wide acceptance throughout the industry.







Absolute Maximum Ratings

	Parameter	Max.	Units
$I_D @ T_C = 25^{\circ}C$	Continuous Drain Current, V _{GS} @ 10V	18	7-1110
$I_D @ T_C = 100^{\circ}C$	Continuous Drain Current, V _{GS} @ 10V	13	А
I _{DM}	Pulsed Drain Current ①	72	
$P_D @ T_C = 25^{\circ}C$	Power Dissipation	45	W
	Linear Derating Factor	0.30	W/°C
V_{GS}	Gate-to-Source Voltage	±16	V
E _{AS}	Single Pulse Avalanche Energy ②	68	mJ
AR	Avalanche Current①	11	A
EAR	Repetitive Avalanche Energy①	4.5	mJ
dv/dt	Peak Diode Recovery dv/dt ③	5.0	V/ns
ΓJ	Operating Junction and	-55 to + 175	V/115
T _{STG}	Storage Temperature Range	-00 10 . 173	°C
	Soldering Temperature, for 10 seconds	300 (1.6mm from case)	-
	Mounting torque, 6-32 or M3 screw.	10 lbf•in (1.1N•m)	

Thermal Resistance

	Parameter	Min.	Тур.	Max.	Units
$R_{\theta JC}$	Junction-to-Case			3.3	
R _{θCS}	Case-to-Sink, Flat, Greased Surface		0.50		°cw
$R_{\theta JA}$	Junction-to-Ambient			62	- 0/00

Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions	
V _{(BR)DSS}	Drain-to-Source Breakdown Voltage	55			V	V _{GS} = 0V, I _D = 250µA	
$\Delta V_{(BR)DSS}/\Delta T_J$	Breakdown Voltage Temp. Coefficient		0.061		V/°C	Reference to 25°C, I _D = 1mA	
R _{DS(on)}	Static Drain-to-Source On-Resistance	_	_	0.060		V _{GS} = 10V, I _D = 11A ④	
		_	_	0.075	Ω	V _{GS} = 5.0V, I _D = 11A ⊕	
		_	_	0.105		V _{GS} = 4.0V, I _D = 9.0A ④	
V _{GS(th)}	Gate Threshold Voltage	1.0		2.0	V	V _{DS} = V _{GS} , I _D = 250µA	
gfs g	Forward Transconductance	8.3			S	V _{DS} = 25V, I _D = 11A	
1	Drain-to-Source Leakage Current			25	μА	V _{DS} = 55V, V _{GS} = 0V	
DSS				250		V _{DS} = 44V, V _{GS} = 0V, T _J = 150°C	
1	Gate-to-Source Forward Leakage			100		V _{GS} = 16V	
GSS	Gate-to-Source Reverse Leakage			-100	nA	V _{GS} = -16V	
Qg	Total Gate Charge			15		I _D = 11A	
Q _{gs}	Gate-to-Source Charge			3.7	nC	V _{DS} = 44V	
Q _{gd}	Gate-to-Drain ("Miller") Charge			8.5	í	V _{GS} = 5.0V, See Fig. 6 and 13 ⊕	
d(on)	Turn-On Delay Time		7.1			V _{DD} = 28V	
r	Rise Time		74			I _D = 11A	
d(off)	Turn-Off Delay Time		20	-	ns	$R_{G} = 12\Omega, V_{GS} = 5.0V$	
f	Fall Time		29			$R_D = 2.4\Omega$, See Fig. 10 @	
L _D	Internal Drain Inductance	_	4.5	_	nН	Between lead, 6mm (0.25in.)	
-S	Internal Source Inductance	_	7.5	_	Ш	from package and center of die contact	
Ciss	Input Capacitance		480	_		V _{GS} = 0V	
Coss	Output Capacitance		130		pF	V _{DS} = 25V	
Crss	Reverse Transfer Capacitance		61			f = 1.0MHz, See Fig. 5	

Source-Drain Ratings and Characteristics

	Parameter	Min.	Тур.	Max.	Units	Conditions	
Is	Continuous Source Current (Body Diode)		_	18		MOSFET symbol showing the	
Ism	Pulsed Source Current (Body Diode) ①	_	_	72	Α .	integral reverse p-n junction diode.	
V _{SD}	Diode Forward Voltage			1.3	V	T _J = 25°C, I _S = 11A, V _{GS} = 0V ④	
t _{rr}	Reverse Recovery Time		60	90	ns	T _J = 25°C, I _F = 11A di/dt = 100A/us ®	
Qrr	Reverse RecoveryCharge		130	200	nC		
ton	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by L _S +L _D)					

Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11)
- $^{\odot}$ V_{DD} = 25V, starting T_J = 25°C, L = 790 μ H R_G = 25 Ω , I_{AS} = 11A. (See Figure 12)
- $\begin{array}{l} \textcircled{3} \ I_{SD} \leq 11A, \ di/dt \leq 290A/\mu s, \ V_{DD} \leq V_{(BR)DSS}, \\ T_{J} \leq 175 \ ^{\circ}\text{C} \\ \textcircled{9} \ \text{Pulse width} \leq 300\mu s; \ duty \ \text{cycle} \leq 2\%. \end{array}$

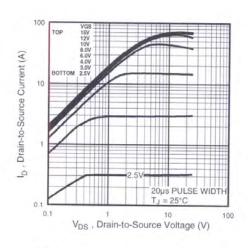


Fig 1. Typical Output Characteristics

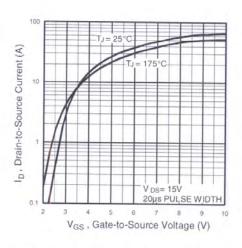


Fig 3. Typical Transfer Characteristics

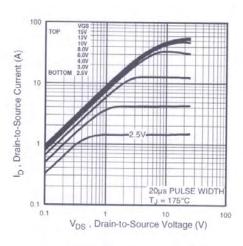


Fig 2. Typical Output Characteristics

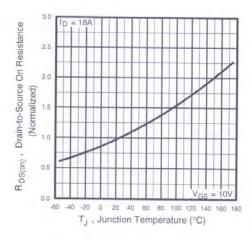


Fig 4. Normalized On-Resistance Vs. Temperature

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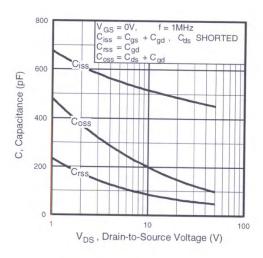


Fig 5. Typical Capacitance Vs. Drain-to-Source Voltage

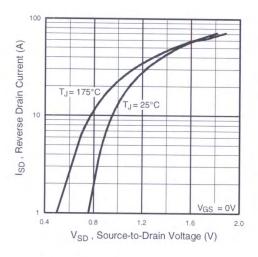


Fig 7. Typical Source-Drain Diode Forward Voltage

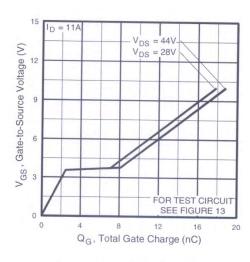


Fig 6. Typical Gate Charge Vs. Gate-to-Source Voltage

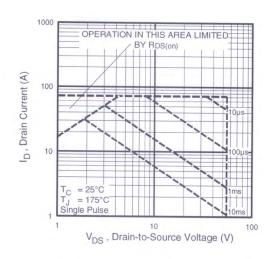


Fig 8. Maximum Safe Operating Area

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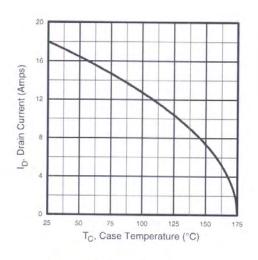


Fig 9. Maximum Drain Current Vs. Case Temperature

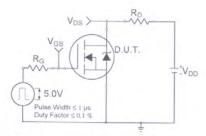


Fig 10a. Switching Time Test Circuit

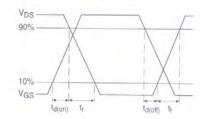


Fig 10b. Switching Time Waveforms

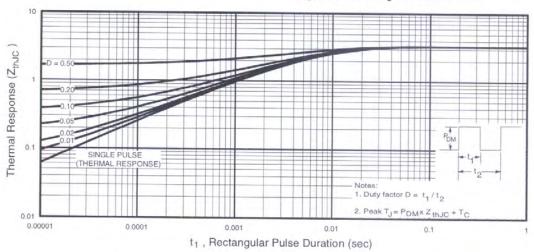


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

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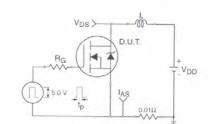


Fig 12a. Unclamped Inductive Test Circuit

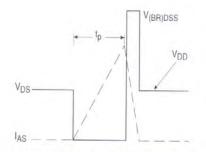


Fig 12b. Unclamped Inductive Waveforms

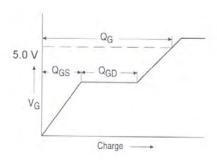


Fig 13a. Basic Gate Charge Waveform

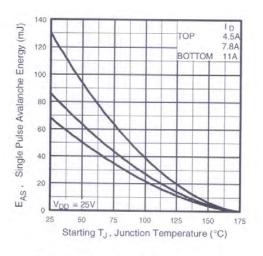


Fig 12c. Maximum Avalanche Energy Vs. Drain Current

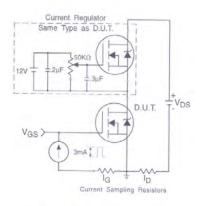


Fig 13b. Gate Charge Test Circuit

Peak Diode Recovery dv/dt Test Circuit Circuit Layout Considerations D.U.T Low Stray Inductance Ground Plane Low Leakage Inductance Current Transformer dv/dt controlled by R_G Driver same type as D.U.T. I_{SD} controlled by Duty Factor "D" D.U.T. - Device Under Test V_{DD} ① Driver Gate Drive $D = \frac{P.W.}{Period}$ Period -P.W.-V_{GS}=10V * D.U.T. I_{SD} Waveform Reverse Recovery Current Body Diode Forward Current di/dt / 3 D.U.T. V_{DS} Waveform Diode Recovery dv/dt V_{DD} Re-Applied Voltage Body Diode Forward Drop 4 nductor Curent

Fig 14. For N-Channel HEXFETS

Ripple ≤ 5%

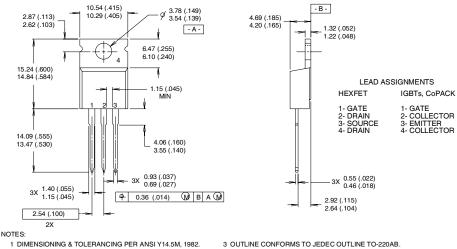
* V_{GS} = 5V for Logic Level Devices

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ISD

TO-220AB Package Outline

Dimensions are shown in millimeters (inches)



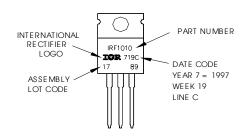
- 1 DIMENSIONING & TOLERANCING PER ANSI Y14.5M, 1982. 2 CONTROLLING DIMENSION : INCH
- 4 HEATSINK & LEAD MEASUREMENTS DO NOT INCLUDE BURBS
- TO-220AB Part Marking Information

EXAMPLE: THIS IS AN IRF1010 LOT CODE 1789

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ASSEMBLED ON WW 19, 1997 IN THE ASSEMBLY LINE "C"

Note: "P" in assembly line position indicates "Lead-Free"



Data and specifications subject to change without notice.



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